

<b>Notice of References Cited</b>  <b>PTO 892</b>	<b>Application/Control No.</b> 09/309,766	<b>Applicant(s)/Patent Under Reexamination</b> Fujimura et al	
	<b>Examiner</b> Kenneth J. Ramsey	<b>Art Unit</b> 2879	<b>Page 1 of 1</b>

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5,697,825-A	12-1997	Dynka et al	445	25
	B					
	C					
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Art Unit: 2879

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
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*	X	**A full Translation of Banno et al was submitted by applicants on 1/20/02					
	Y						
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